## Notice of References Cited Application/Control No. 10/750,028 Examiner KYUNG H. SHIN Applicant(s)/Patent Under Reexamination MEYERS ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number	Date	Name	01:(
Ĺ		Country Code-Number-Kind Code	MM-YYYY	Name	Classification
*	Α	US-6,437,803 B1	08-2002	Panasyuk et al.	715/733
*	В	US-6,662,207 B2	12-2003	Kawamura et al.	709/202
*	C	US-6,983,328 B2	01-2006	Beged-Dov et al.	709/230
*	D	US-7,171,444 B2	01-2007	Deshpande, Sachin G.	709/203
	ш	US-			
	F	US-			
	O	US-			
	Η	US-			
	Ι	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.